

N-channel 30 V 1.1 mΩ logic level MOSFET in D2PAKRev. 1 — 3 February 2011Objective

Objective data sheet

Product profile 1.

1.1 General description

Logic level N-channel MOSFET in D2PAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for logic level gate drive sources

1.3 Applications

- DC-to-DC converters
- Load switching

- Motor control
- Server power supplies

1.4 Quick reference data

Table 1. **Quick reference data**

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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	30	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 1</u>	<u>[1]</u>	-	-	120	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	-	306	W
Tj	junction temperature			-55	-	175	°C
Static cha	racteristics						
DOON	drain-source on-state	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; see <u>Figure 12</u>		-	1	1.1	mΩ
	resistance	V _{GS} = 10 V; I _D = 25 A; T _i = 100 °C; see <u>Figure 13</u>		-	1.53	1.8	mΩ



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Table 1. Quick reference data ... continued

Symbol	Parameter	Conditions	Mi	n Typ	Мах	Unit
Dynamic of	characteristics					
Q_{GD}	gate-drain charge		-	37	-	nC
Q _{G(tot)}	total gate charge	V _{DS} = 15 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	<u>14;</u>		-	nC
Avalanche	Avalanche ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy		-	-	1.9	J

[1] Continuous current is limited by package.

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		-
2	D	drain ^[1]	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S
			SOT404 (D2PAK)	

[1] It is not possible to make connection to pin 2

3. Ordering information

Table 3.Ordering information

Type number	Package		
	Name	Description	Version
PSMN1R1-30BL	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

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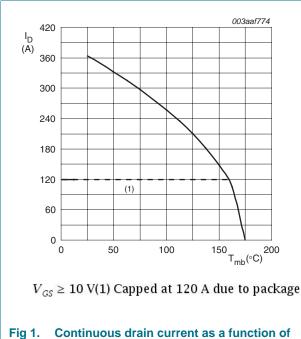
4. Limiting values

Table 4. Limiting values

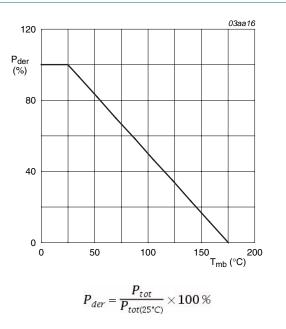
In accordance with the Absolute Maximum Rating System (IEC 60134).

		33 ()				
Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	30	V
V _{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$		-	30	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 100 °C; see Figure 1	<u>[1]</u>	-	120	А
		V_{GS} = 10 V; T_{mb} = 25 °C; see Figure 1	<u>[1]</u>	-	120	А
I _{DM}	peak drain current	pulsed; t _p ≤ 10 µs; T _{mb} = 25 °C; see <u>Figure 3</u>		-	1456	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	306	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
T _{sld(M)}	peak soldering temperature			-	260	°C
Source-drai	n diode					
Is	source current	T _{mb} = 25 °C	<u>[1]</u>	-	120	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	1456	А
Avalanche r	uggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$ \begin{array}{l} V_{GS} = 10 \; V; \; T_{j(\text{init})} = 25 \; ^{\circ}\text{C}; \; I_{D} = 120 \; A; \\ V_{sup} \leq 30 \; V; \; R_{GS} = 50 \; \Omega; \; unclamped \end{array} $		-	1.9	J

[1] Continuous current is limited by package.



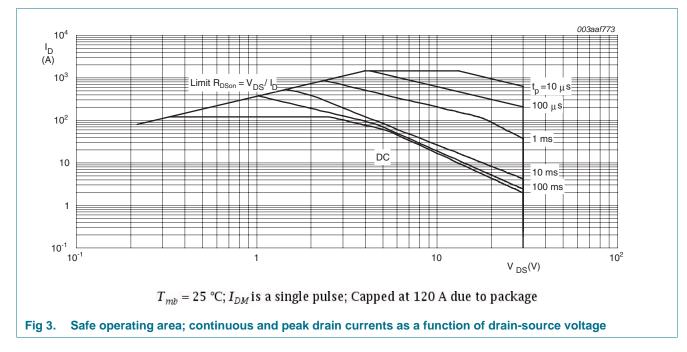






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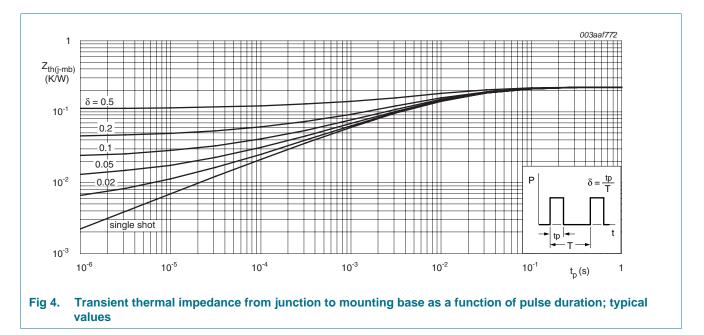
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5. Thermal characteristics

Table 5.Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	0.22	0.49	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	50	-	K/W



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Characteristics 6.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _i = 25 °C	30	-	-	V
. ,	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	27	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 10</u> ; see <u>Figure 11</u>	1.3	1.7	2.2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 11	0.65	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 11</u>	-	-	2.5	V
I _{DSS}	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	1	μA
		V _{DS} = 30 V; V _{GS} = 0 V; T _j = 175 °C	-	250	500	μA
I _{GSS}	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	10	100	nA
		$V_{GS} = -16 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
R _{DSon} drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 12</u>	-	1	1.1	mΩ	
		V _{GS} = 10 V; I _D = 25 A; T _j = 175 °C; see <u>Figure 12</u> ; see <u>Figure 13</u>	-	2	2.3	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 100 °C; see <u>Figure 13</u>	-	1.53	1.8	mΩ
R _G	gate resistance	f = 1 MHz	-	1.1	-	Ω
Dynamic cl	haracteristics					
$Q_{G(tot)}$ total gate charge	$I_D = 75 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	243	-	nC	
		$I_D = 0 \text{ A}; V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	222	-	nC
		$I_D = 75 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	118	-	nC
Q _{GS}	gate-source charge	see Figure 14; see Figure 15	-	39	-	nC
Q _{GS(th)}	pre-threshold gate-source charge		-	22	-	nC
Q _{GS(th} -pl)	post-threshold gate-source charge		-	17	-	nC
Q _{GD}	gate-drain charge		-	37	-	nC
V _{GS(pl)}	gate-source plateau voltage	V _{DS} = 15 V; see <u>Figure 14;</u> see <u>Figure 15</u>	-	2.8	-	V
C _{iss}	input capacitance	V_{DS} = 15 V; V_{GS} = 0 V; f = 1 MHz;	-	14850	-	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } Figure 16$	-	2799	-	pF
C _{rss}	reverse transfer capacitance		-	1215	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 15 \text{ V}; \text{ R}_{L} = 0.2 \Omega; V_{GS} = 5 \text{ V};$ $R_{G(ext)} = 5 \Omega; \text{ I}_{D} = 75 \text{ A}; \text{ T}_{j} = 25 \text{ °C}$	-	95.3	-	ns
t _r	rise time	$V_{DS} = 15 \text{ V}; \text{ R}_{L} = 0.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$ $\text{R}_{G(ext)} = 5 \Omega; \text{ T}_{I} = 25 \text{ °C}$	-	213	-	ns

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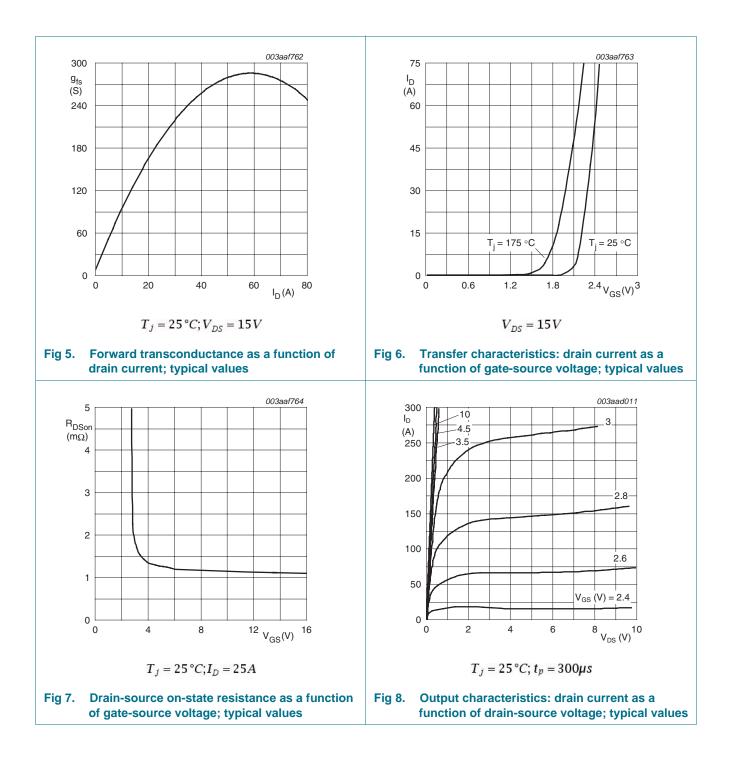
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Parameter	Conditions	Min	Тур	Max	Unit
turn-off delay time	$V_{DS} = 15 \text{ V}; \text{ R}_{L} = 0.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	199	-	ns
fall time	$R_{G(ext)} = 5 \Omega; I_D = 75 A; T_j = 25 °C$	-	115	-	ns
rain diode					
source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 17</u>	-	0.8	1.2	V
reverse recovery time	$I_{S} = 25 \text{ A}; dI_{S}/dt = -100 \text{ A}/\mu s; V_{GS} = 0 \text{ V};$	-	67	-	ns
recovered charge	V _{DS} = 15 V	-	123	-	nC
	turn-off delay time fall time rain diode source-drain voltage reverse recovery time	turn-off delay time $V_{DS} = 15 \text{ V}; \text{ R}_{L} = 0.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$ fall time $R_{G(ext)} = 5 \Omega; \text{ I}_{D} = 75 \text{ A}; \text{ T}_{j} = 25 \text{ °C}$ rain diodeIs = 25 A; V_{GS} = 0 V; T_{j} = 25 \text{ °C};see Figure 17Is = 25 A; dIs/dt = -100 A/\mus; V_{GS} = 0 V;V = = 15 VIs = 25 A; dIs/dt = -100 A/\mus; V_{GS} = 0 V;	turn-off delay time $V_{DS} = 15 \text{ V}; \text{ R}_L = 0.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$ fall time-fall time $R_{G(ext)} = 5 \Omega; I_D = 75 \text{ A}; T_j = 25 \text{ °C}$ -rain diode $I_S = 25 \text{ A}; \text{ V}_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see Figure 17-reverse recovery time $I_S = 25 \text{ A}; dI_S/dt = -100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = 0 \text{ V};$ -	turn-off delay time $V_{DS} = 15 \text{ V}; \text{ R}_{L} = 0.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$ -199fall time $R_{G(ext)} = 5 \Omega; I_{D} = 75 \text{ A}; T_{j} = 25 \text{ °C}$ -115rain diodesource-drain voltageI_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_{j} = 25 \text{ °C};-0.8reverse recovery timeI_S = 25 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};-67	turn-off delay time $V_{DS} = 15 \text{ V}; \text{ R}_L = 0.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$ - 199 - fall time $R_{G(ext)} = 5 \Omega; I_D = 75 \text{ A}; \text{ T}_j = 25 \text{ °C}$ - 115 - rain diode Is = 25 \text{ A}; V_{GS} = 0 \text{ V}; \text{ T}_j = 25 \text{ °C}; - 0.8 1.2 reverse recovery time Is = 25 \text{ A}; dIs/dt = -100 \text{ A/} \mu s; V_{GS} = 0 \text{ V}; - 67 -

Table 6. Characteristics ...continued

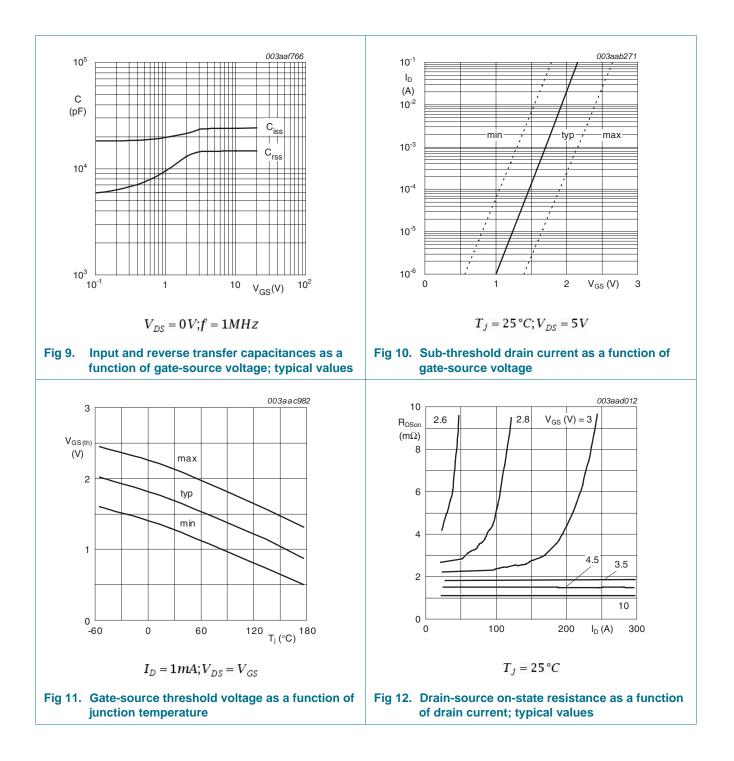
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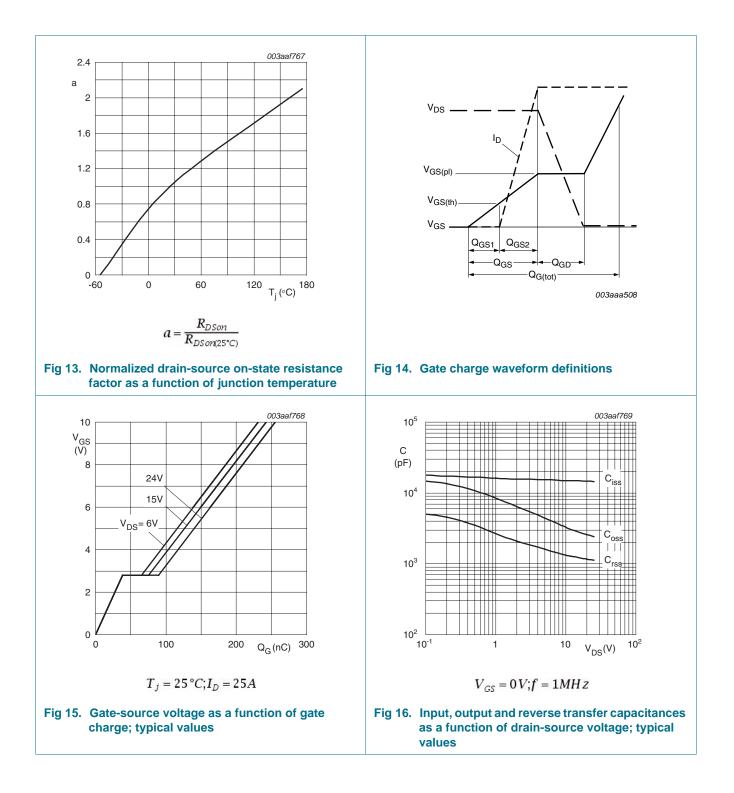
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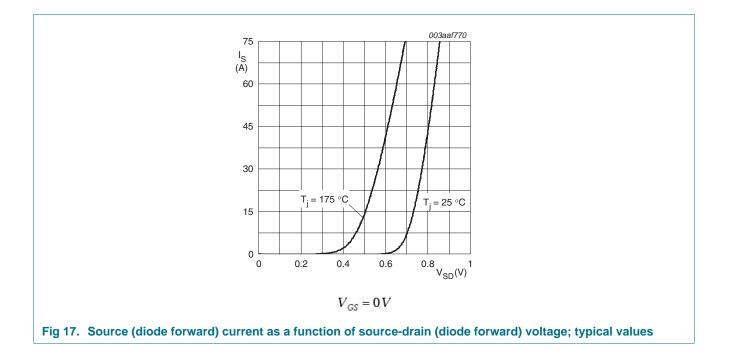
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7. Package outline

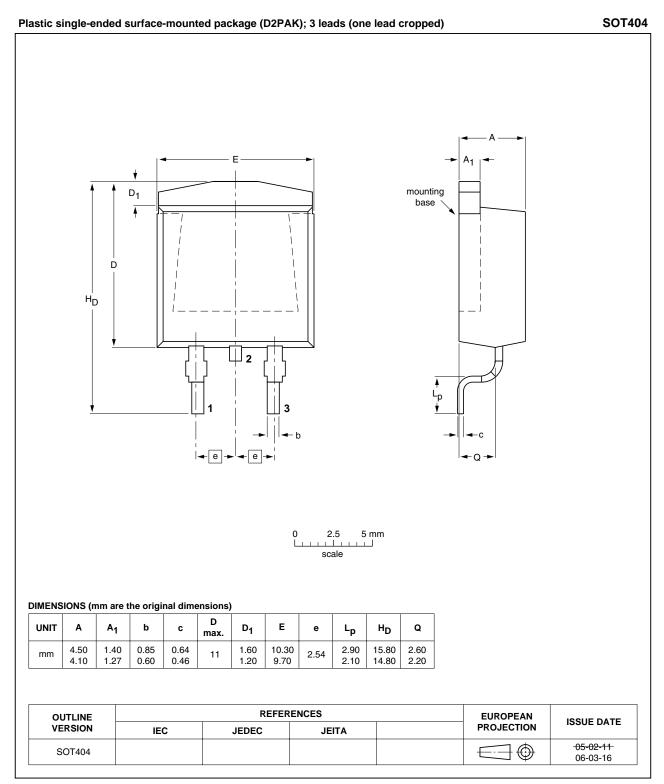


Fig 18. Package outline SOT404 (D2PAK)

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8. Revision history

Table 7. Revision h	able 7. Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes		
PSMN1R1-30BL v.1	20110203	Objective data sheet	-	-		

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9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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